

INFORMATION DISCLOSURE CITATION

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PTO Form 1449

Attorney Docket No.:

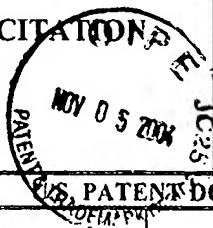
046124-5281

Application No.: 10/804,195

Applicants: Hirotoshi TERADA et al.

Filing Date: March 19, 2004

Group Art Unit: 2872



PATENT DOCUMENTS

*Examiner Initial	Document Number	Date	Name	Class	Sub Class	Filing Date

NONE

FOREIGN PATENT DOCUMENTS

	Document Number	Date	Country	Class	Sub Class	Translation YES NO
RP	2002-236087	08/23/2002	Japan			Abstract
RP	2002-121930	04/28/2000	Japan			Abstract

OTHER DOCUMENTS (Including author, title, Date, Pertinent Pages, Etc.)

NONE

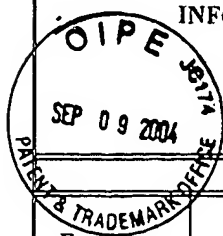
Examiner

Shen 2 R. L. H. T. H.

Date Considered

1/18/05

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(Use several sheets if necessary)

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U.S. PATENT DOCUMENTS

Examiner Initial	Document Number	Date	Name	Class	Sub Class	Filing Date
JP	5,939,709	August 17, 1999	Ghislain et al.	250	216	June 19, 1997
JP	5,422,498	June 6, 1995	Nikawa et al.	257	48	April 13, 1994
JP	5,208,648	May 4, 1993	Batchelder et al.	356	237	March 11, 1991
JP	5,220,403	June 15, 1993	Batchelder et al.	356	345	September 30, 1992
JP	5,004,307	April 2, 1991	Kino et al.	350	1.2	April 12, 1990
JP	5,125,750	June 30, 1992	Corle et al.	359	819	March 14, 1991
JP	6,594,086 B1	July 15, 2003	Pakdamian et al.	359	656	January 16, 2002
JP	6,475,398 B2	November 5, 2002	Kitahata	216	2	September 25, 2001
JP	6,608,359 B2	August 19, 2003	Kitahata	257	432	August 29, 2002
JP	6,656,029 B2	December 2, 2003	Kitahata	451	384	August 29, 2002
JP	6,621,275 B2	September 16, 2003	Cotton et al.	324	537	November 28, 2001
JP	6,002,792	December 14, 1999	Oguri et al.	382	145	February 29, 1996
JP	6,687,058 B1	February 3, 2004	Ippolito et al.	359	656	June 20, 2000
JP	6,441,359 B1	August 27, 2002	Cozier et al.	250	216	October 7, 1999
JP	2003/0202255 A1	October 30, 2003	Pakdamian et al.	359	656	May 19, 2003
JP	2003/0210057 A1	November 13, 2003	Cotton et al.	324	501	June 9, 2003

FOREIGN PATENT DOCUMENTS

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JP	JP 2002-189000 (corresponds to USP Nos. 6,475,398, 6,608,359 & 6,656,029)	July 5, 2002	Japan			Abstract	
JP	JP 05-157701 (corresponds to USP Nos. 5,208,648 & 5,220,403)	June 25, 1993	Japan			Abstract	
JP	JP 06-300824 (corresponds to USP 5,422,498)	October 28, 1994	Japan			Abstract	
JP	JP 07-190946 (corresponds to USP 6,002,792)	July 28, 1995	Japan			Abstract	
JP	JP 7-18806 (corresponds to USP Nos. 5,208,648 & 5,220,403)	March 6, 1995	Japan			Abstract	
JP	JP 11-003534	January 6, 1999	Japan			Abstract	
JP	JP 2001-023230	January 26, 2001	Japan			Abstract	
JP	EP 0 977 192 A1	February 2, 2000	Europe				

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JP	ISTFA, November 2003, "Conference Proceedings from the 29th International Symposium for Testing and Failure Analysis", pp. 325-329.
JP	ISTFA 2003, "Photomission and OBIRCH Analysis with Solid Immersion Lens (SIL)", pp. 1-20.

Examiner

Date Considered 11/18/05

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